

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/044,195	SYED, MAJID	
Examiner		Art Unit		Page 1 of 1
Thuong (Tina) T. Nguyen		2455		

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-5,615,249 A	03-1997	Solondz, Max A.	455/450
*	B US-6,944,430 B2	09-2005	Berstis, Viktors	455/186.1
*	C US-2002/0044567 A1	04-2002	Voit et al.	370/467
*	D US-5,935,218 A	08-1999	Beyda et al.	709/251
*	E US-6,782,510 B1	08-2004	Gross et al.	715/257
*	F US-7,275,254 B1	09-2007	Jutzi, Curtis E.	725/72
*	G US-2003/0009765 A1	01-2003	Linden et al.	725/95
*	H US-6,549,938 B1	04-2003	Kikki et al.	709/207
*	I US-6,904,265 B1	06-2005	Valdivia et al.	455/12.1
J	US-			
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
U				
V				
W				
X				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.